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| Notice of References Cited | Application/Control No. 09/898,293 | Applicant(s)/Patent Under Reexamination EOM, MIN YOUNG | |
| | Examiner Thien D Tran | Art Unit 2665 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2001/0024436 | 09-2001 | Barracclough et al. | 370/352 |
| * | B | US-2002/0001302 | 01-2002 | Pickett, Scott K. | 370/352 |
| * | C | US-6,804,224 | 10-2004 | Schuster et al. | 370/352 |
| * | D | US-6,487,196 | 11-2002 | Verthein et al. | 370/352 |
| * | E | US-6,526,581 | 02-2003 | Edson, Richard | 725/74 |
| * | F | US-6,785,267 | 08-2004 | Knappe, Michael E. | 370/353 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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